

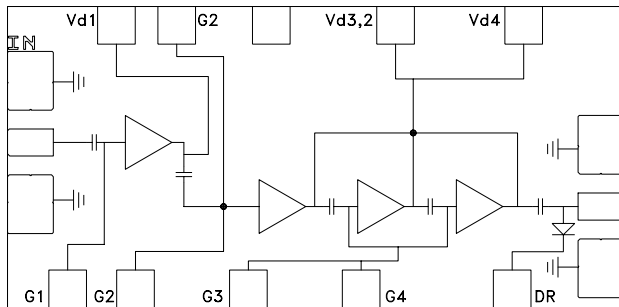
GaAs MMIC MEDIUM POWER AMPLIFIER, 17 - 40 GHz

Typical Applications

The HMC283 MPA is ideal for:

- Millimeterwave Point-to-Point Radios
- VSAT
- SATCOM

Functional Diagram



Features

- High Gain: 21 dB
- Psat Output Power: +21 dBm
- Wideband Performance: 17 - 40 GHz
- Small Chip Size: 0.88 mm x 1.72 mm

General Description

The HMC283 chip is a four stage GaAs MMIC Medium Power Amplifier (MPA) which covers the frequency range of 17 to 40 GHz. The chip can easily be integrated into Multi-Chip Modules (MCMs) due to its small (1.62 mm²) size. The chip utilizes a GaAs PHEMT process offering 20 dB gain and +21 dBm output power from a bias supply of +3.5V @ 300mA. The HMC283 may be used as a frequency doubler. A B.I.T. (Built-In-Test) pad (Vdet) allows monitoring microwave output power. All data is with the chip in a 50 ohm test fixture connected via 0.076mm x 0.0127mm (3mil x 0.5mil) ribbon bonds of minimal length 0.31mm (<12mils).

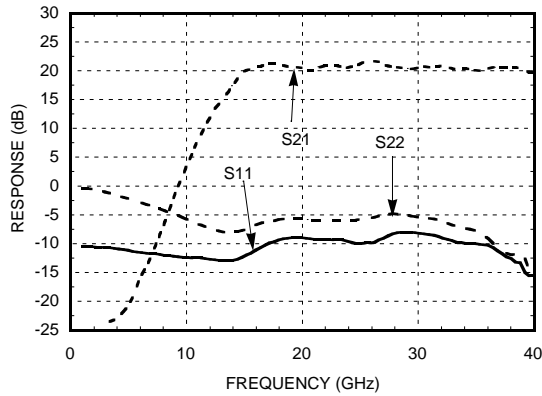
Electrical Specifications, $T_A = +25^\circ C$, $V_{dd} = +3.5V^*$, $I_{dd} = 300 mA$

Parameter	Min.	Typ.	Max.	Units
Frequency Range	17 - 40			GHz
Gain	16	21		dB
Gain Flatness (Any 1 GHz BW)		±0.8		dB
Input Return Loss		9		dB
Output Return Loss		6		dB
Reverse Isolation	40	50		dB
Output Power for 1 dB Compression (P1dB)	14	18		dBm
Saturated Output Power (Psat)	17	21		dBm
Output Third Order Intercept (IP3)	21	26		dBm
Noise Figure		10	14	dB
Supply Current (I _{dd})(V _{dd} = +3.5V, V _{gg} = -0.15V Typ.)		300	400	mA

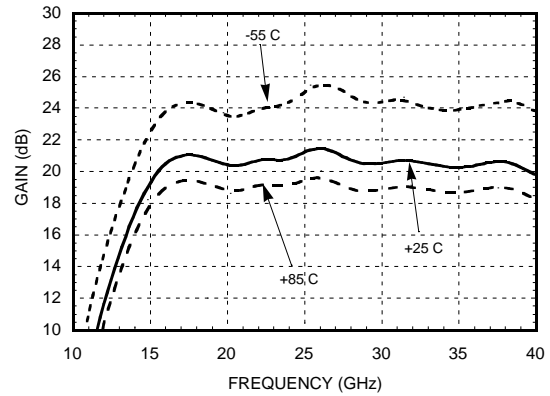
*V_{dd} = V_{d1}, 2, 3, 4 connected to +3.5V, adjusting V_{gg} = V_{g1}, 2, 3, 4 between -2.0 to +0.4V to achieve I_{dd} = 300 mA typical.

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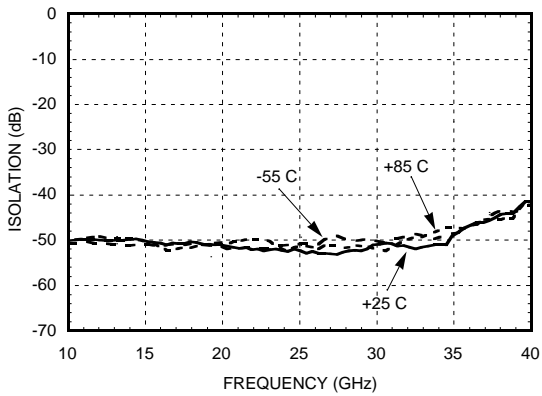
Broadband Gain & Return Loss



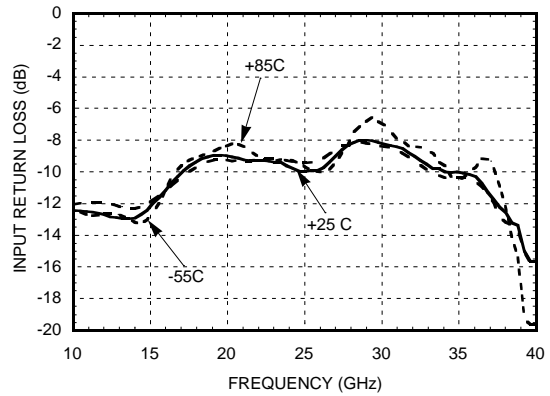
Gain vs. Temperature



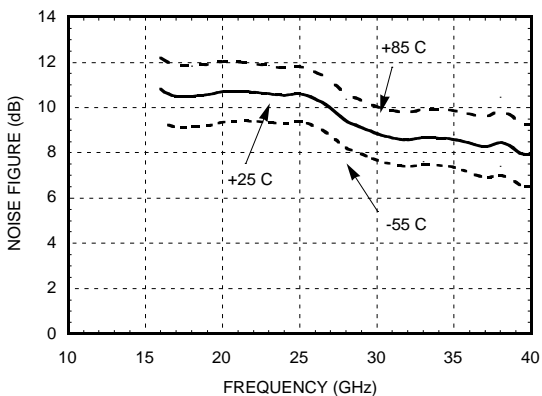
Reverse Isolation vs. Temperature



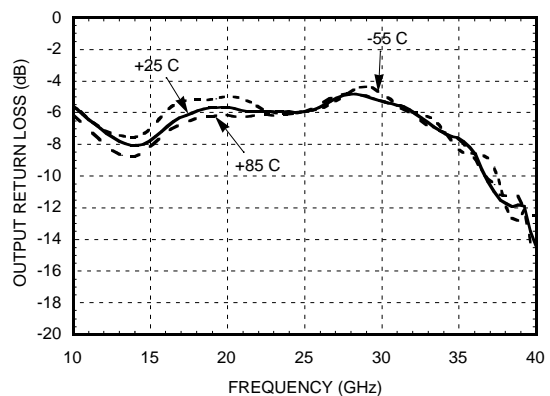
Input Return Loss vs. Temperature



Noise Figure vs. Temperature



Output Return Loss vs. Temperature

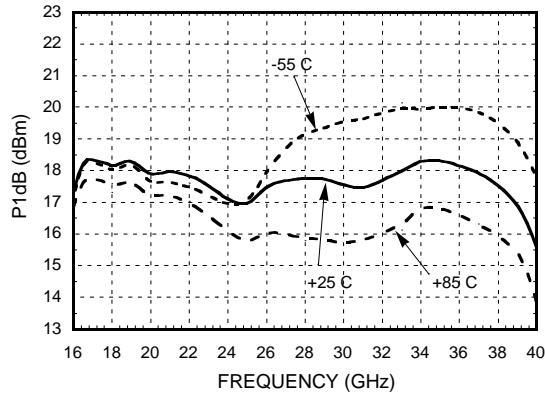


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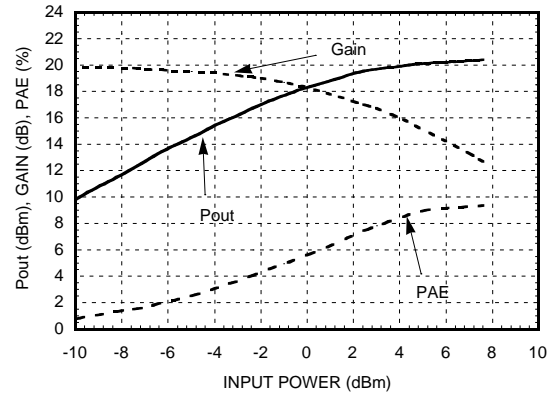
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AMPLIFIERS - CHIP

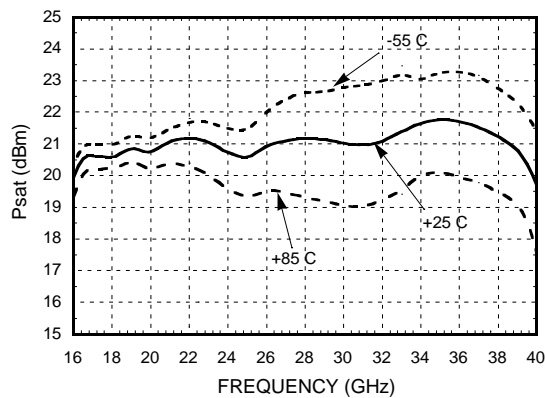
P1dB vs. Temperature



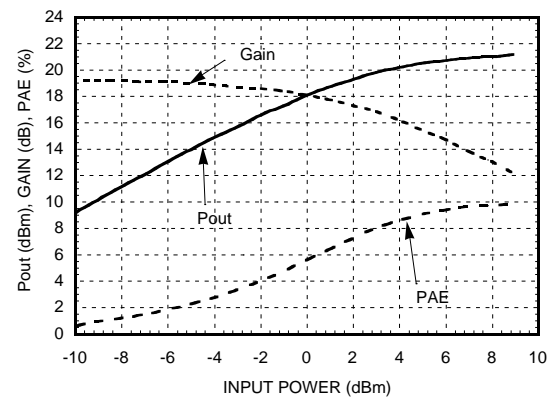
Power Compression @ 20 GHz



Psat vs. Temperature



Power Compression @ 28 GHz

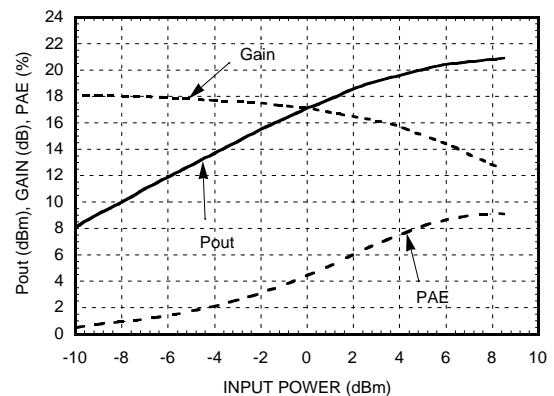


Output IP3 vs. Temperature

	Frequency (GHz)		
Temperature	20	28	38
-55 °C	25.6	25.4	28.6
+25 °C	27.5	25.9	27.1
+85 °C	27	24.4	25.7

All levels in dBm

Power Compression @ 39 GHz

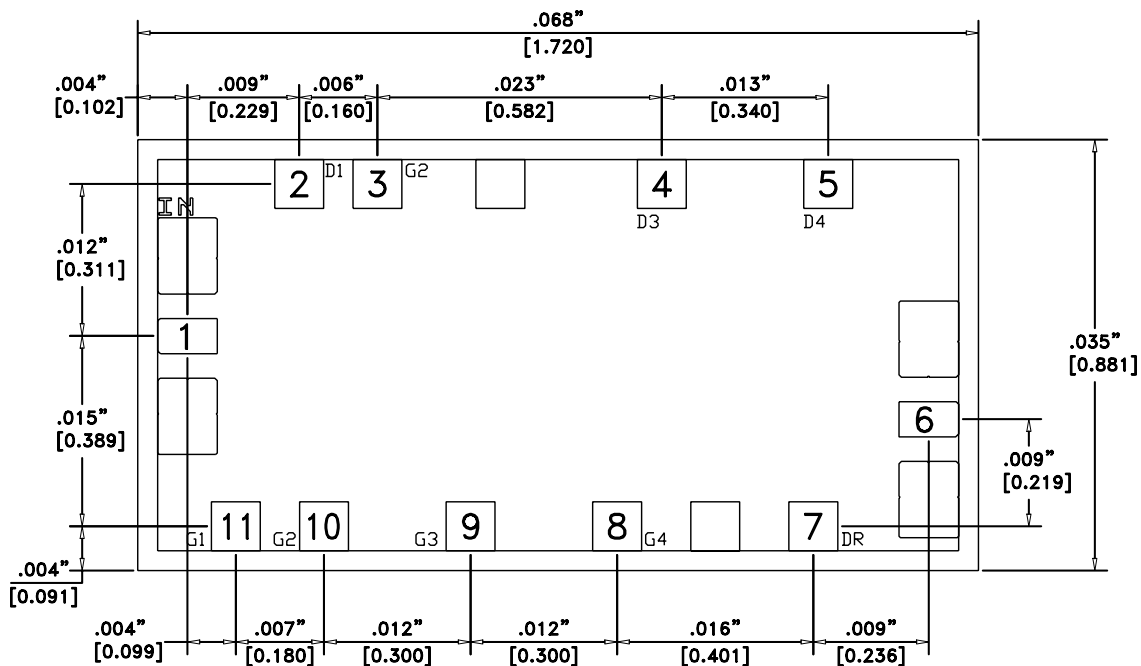


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Absolute Maximum Ratings

Drain Bias Voltage (Vdd1, Vdd2, Vdd3, Vdd4)	+5.0 Vdc
Drain Bias Current (Idd)	400 mA
Gate Bias Voltage (Vgg1, Vgg2, Vgg3, Vgg4)	-2 to +0.4Vdc
Gate Bias Current (Igg)	4 mA
RF Input Power (RFIn)(Vdd = +3.0 Vdc)	+10 dBm
Channel Temperature	175 °C
Continuous Pdiss (T = 85 °C) (derate 13.04 mW/°C above 85 °C)	1.174 W
Thermal Resistance (channel to die bottom)	76.7 °C/W
Storage Temperature	-65 to +150 °C
Operating Temperature	-55 to +85 °C

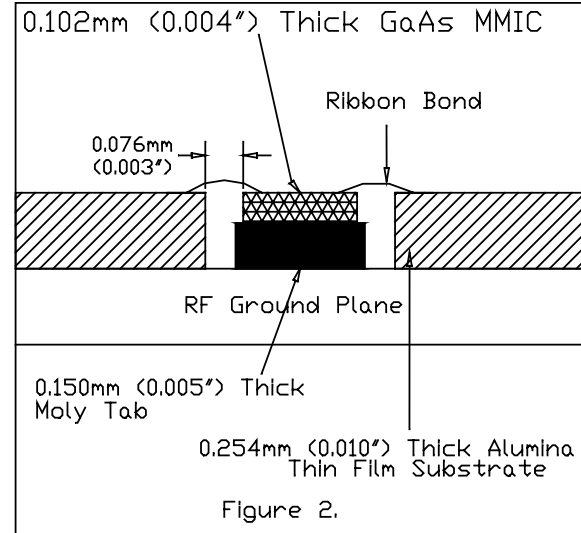
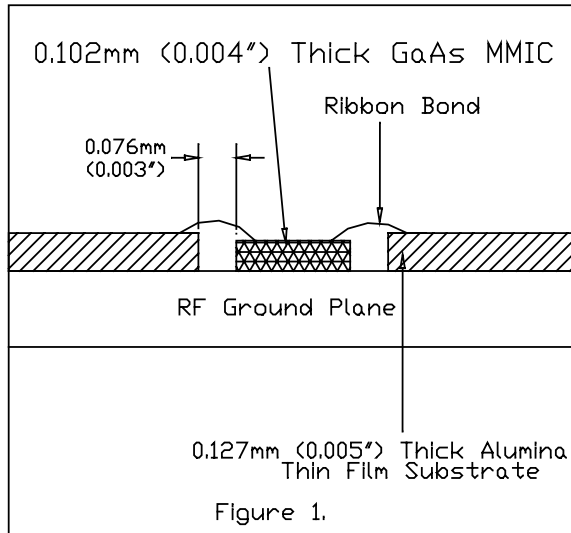
Outline Drawing



NOTES:

1. ALL DIMENSIONS ARE IN INCHES [MM]
2. DIE THICKNESS IS .004"
3. TYPICAL BOND IS .004" SQUARE
4. BACKSIDE METALLIZATION: GOLD
5. BOND PAD METALLIZATION: GOLD
6. BACKSIDE METAL IS GROUND.
7. CONNECTION NOT REQUIRED FOR UNLABELED BOND PADS.

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Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note.)

50 Ohm Microstrip transmission lines on 0.127 mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254 mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150 mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102 mm (4 mil) thick die to a 0.150 mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be brought as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076 mm (3 mils).

Gold ribbon of 0.076 mm x 0.013 mm (3 mil x 0.5 mil) is recommended to minimize inductance on the RF ports. 0.025 mm (1 mil) diameter ball or wedge bonds are acceptable for DC bias connections.

RF bypass capacitors should be used on the Vdd & Vgg inputs. 100 pF single layer capacitors (mounted eutectically or by conductive epoxy) placed no further than 0.762 mm (30 mils) from the chip are recommended. The photo in figure 3 shows a typical assembly for the HMC283 MMIC chip.

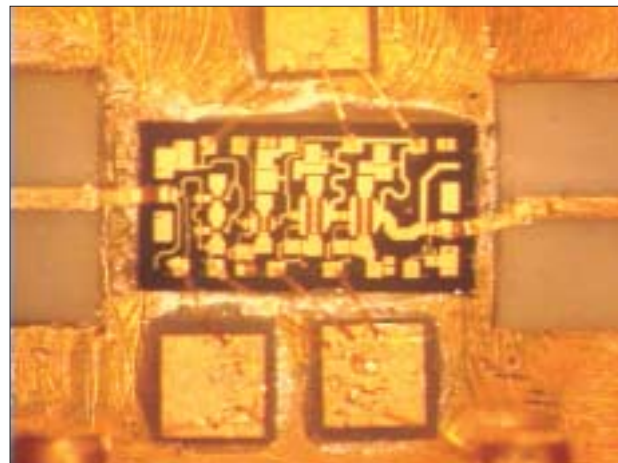
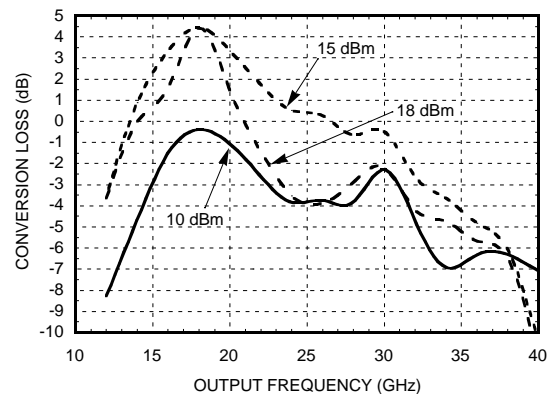


Figure 3: Typical HMC283 Assembly

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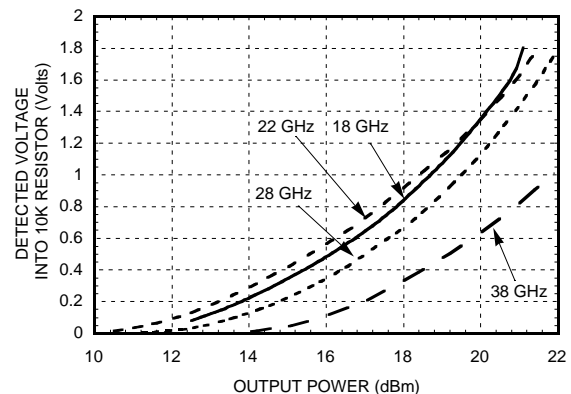
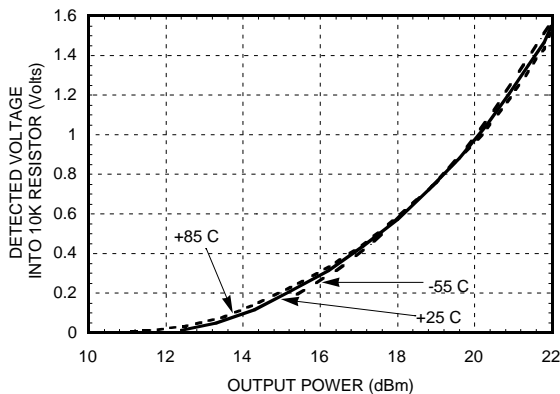
HMC283 Alternate Applications: HMC283 Frequency Multiplier Performance

HMC283 can also perform as a frequency multiplier. This is accomplished by biasing Vg1 into its pinchoff region - typically -1V to -2V. By adjusting the Vg1 bias, the device will operate as a doubler or tripler. Vg2 may also be adjusted to minimize the levels of unwanted harmonics. The plot shows the performance of HMC283 operated as a doubler with Vg1 = -1V and the remaining gate voltages (Vg2, 3, 4) set to -0.15V. In this condition the amplifier draws 310mA at 3.5V drain bias (Vdd) and provides +5dB to -5dB conversion loss dependent upon the output frequency.



HMC283 Voltage Detector, Built-In-Test (B.I.T.)

By connecting the Vdet port to a 10K Ohm resistor and monitoring the voltage, a B.I.T. circuit can be created to monitor changes in the device output power. This circuit is extremely well compensated for temperature variations as shown in the first plot. The detected voltage does change with frequency and the second plot shows its variation.



**GaAs MMIC MEDIUM POWER
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Follow these precautions to avoid permanent damage.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against $> \pm 250V$ ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet or with a sharp pair of bent tweezers. The surface of the chip has fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

Eutectic Die Attach:

A 80/20 gold tin preform is recommended with a work surface temperature of 255 deg. C and a tool temperature of 265 deg. C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 deg. C. DO NOT expose the chip to a temperature greater than 320 deg. C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach:

Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025 mm (1 mil) diameter pure gold wire (DC Bias) or ribbon bond (RF ports) 0.076 mm x 0.013 mm (3 mil x 0.5 mil) size is recommended. Thermosonic wirebonding with a nominal stage temperature of 150 deg. C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible < 0.31 mm (12 mils).

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Notes:

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